











**SN74LVCH16652A** 

SCAS319J-NOVEMBER 1993-REVISED DECEMBER 2014

## SN74LVCH16652A 16-Bit Bus Transceiver and Register with 3-State Outputs

#### **Features**

- Member of the Texas Instruments Widebus™
- Operates From 1.65 V to 3.6 V
- Inputs Accept Voltages to 5.5 V
- Max  $t_{pd}$  of 6.3 ns at 3.3 V
- Typical V<sub>OLP</sub> (Output Ground Bounce)  $< 0.8 \text{ V at V}_{CC} = 3.3 \text{ V}, T_A = 25^{\circ}\text{C}$
- Typical V<sub>OHV</sub> (Output V<sub>OH</sub> Undershoot)  $> 2 \text{ V at V}_{CC} = 3.3 \text{ V}, T_A = 25^{\circ}\text{C}$
- Supports Mixed-Mode Signal Operation on All Ports (5-V Input/Output Voltage With 3.3-V  $V_{CC}$ )
- Ioff Supports Partial-Power-Down Mode Operation
- Bus Hold on Data Inputs Eliminates the Need for External Pull-up or Pull-down Resistors
- Latch-Up Performance Exceeds 250 mA Per JESD 17
- ESD Protection Exceeds JESD 22
  - 2000-V Human-Body Model
  - 200-V Machine Model
  - 1500-V Charged-Device Model

## **Applications**

- Servers
- PCs, Notebooks
- Network switches
- Telecom Infrastructure
- I/O Expanders

## Description

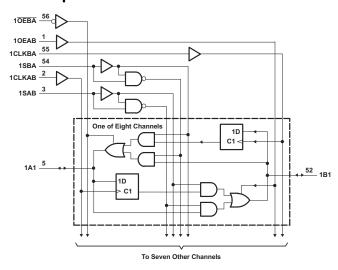
This 16-bit bus transceiver and register is designed for 1.65-V to 3.6-V  $V_{CC}$  operation.

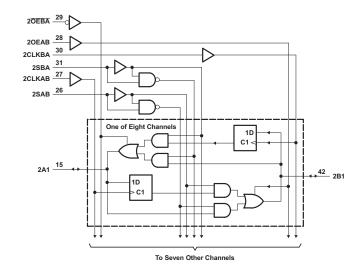
#### Device Information<sup>(1)</sup>

PART NUMBER	PACKAGE	BODY SIZE (NOM)				
	SSOP (56)	18.40 mm x 7.50 mm				
SN74LVCH16652A	TSSOP (56)	14.00 mm x 6.10 mm				
	TVSOP (56)	11.30 mm x 4.40 mm				

(1) For all available packages, see the orderable addendum at the end of the datasheet.

## Simplified Schematic







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## 5 Revision History

### Changes from Revision I (March 2005) to Revision J

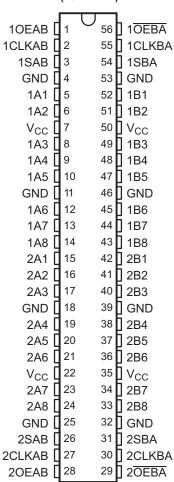
**Page** 

Added Applications, Device Information table, Pin Functions table, ESD Ratings table, Thermal Information table,
Typical Characteristics, Feature Description section, Device Functional Modes, Application and Implementation
section, Power Supply Recommendations section, Layout section, Device and Documentation Support section, and
Mechanical, Packaging, and Orderable Information section.



## 6 Pin Configuration and Functions

# DGG, DGV, OR DL PACKAGE (TOP VIEW)



#### **Pin Functions**

F	IN	TYPE	DESCRIPTION
NO.	NAME	ITPE	DESCRIPTION
1	10EAB	I	10EAB Input. Active-high enable for A-to-B directional data.
2	1CLKAB	I	1CLKAB Input. Clock input for D flip-flop from A to B.
3	1SAB	1	1SAB Input. Data select from A to B: A high level selects stored data and a low-level selects real-time data.
4	GND	_	GND
5	1A1	I/O	1A1 Input/Output
6	1A2	I/O	1A2 Input/Output
7	V <sub>CC</sub>	_	Power Pin
8	1A3	I/O	1A3 Input/Output
9	1A4	I/O	1A4 Input/Output
10	1A5	I/O	1A5 Input/Output
11	GND	_	Ground Pin
12	1A6	I/O	1A6 Input/Output
13	1A7	I/O	1A7 Input/Output
14	1A8	I/O	1A8 Input/Output



## Pin Functions (continued)

	in Functions (C	,
	TYPE	DESCRIPTION
		2A1 Input/Output
		2A2 Input/Output
	I/O	2A3 Input/Output
	_	Ground Pin
	I/O	2A4 Input/Output
	I/O	2A5 Input/Output
	I/O	2A6 Input/Output
V <sub>CC</sub>	_	Power Pin
2A7	I/O	2A7 Input/Output
2A8	I/O	2A8 Input/Output
GND	_	Ground Pin
2SAB	I	2SAB Input. Data select from A to B: A high level selects stored data and a low-level selects real-time data.
2CLKAB	I	2CLKAB Input. Clock input for D flip-flop from A to B.
20EAB	I	20EAB Input. Active-high enable for A-to-B directional data.
2 <mark>OEBA</mark>	I	2OEBA Input. Active-low enable for B-to-A directional data.
2CLKBA	I	2CLKBA Input. Clock input for D flip-flop from B to A.
2SBA	I	2SBA Input. Data select from B to A: A high level selects stored data and a low-level selects real-time data.
GND	_	Ground Pin
2B8	I/O	2B8 Input/Output
2B7	I/O	2B7 Input/Output
V <sub>cc</sub>	_	Power Pin
2B6	I/O	2B6 Input/Output
2B5	I/O	2B5 Input/Output
2B4	I/O	2B4 Input/Output
GND	-	Ground Pin
2B3	I/O	2B3 Input/Output
2B2	I/O	2B2 Input/Output
2B1	_	2B1 Input/Output
1B8	I/O	1B8 Input/Output
1B7	I/O	1B7 Input/Output
1B6	I/O	1B6 Input/Output
GND	_	Ground Pin
1B5	I/O	1B5 Input/Output
1B4	I/O	1B4 Input/Output
1B3	I/O	1B3 Input/Output
V <sub>CC</sub>	_	Power Pin
1B2	I/O	1B2 Input/Output
1B1	I/O	1B1 Input/Output
GND	_	Ground Pin
1SBA	i	1SBA Input. Data select from B to A: A high-level selects stored data and a low-level selects real-time data.
1CLKBA	I	1CLKBA Input. Clock input for D flip-flop from B to A.
1 <del>OEBA</del>	I	1OEBA Input. Active-low enable for B-to-A directional data.
	2A8 GND 2SAB 2CLKAB 2OEAB 2OEBA 2OEBA 2CLKBA 2SBA GND 2B8 2B7 V <sub>CC</sub> 2B6 2B5 2B4 GND 2B3 2B2 2B1 1B8 1B7 1B6 GND 1B5 1B4 1B3 V <sub>CC</sub> 1B2 1B1 GND 1SBA	NAME   2A1



## 7 Specifications

## 7.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

			MIN	MAX	UNIT
$V_{CC}$	Supply voltage range		-0.5	6.5	V
VI	Input voltage range (2)			6.5	V
Vo	Voltage range applied to any output in the high-impedance or power-off state (2)			6.5	V
Vo	Vo Voltage range applied to any output in the high or low state (2) (3)			V <sub>CC</sub> + 0.5	V
I <sub>IK</sub>	Input clamp current	V <sub>I</sub> < 0		<b>-</b> 50	mA
I <sub>OK</sub>	Output clamp current	V <sub>O</sub> < 0		<b>-</b> 50	mA
Io	Continuous output current			±50	mA
	Continuous current through V <sub>CC</sub> or GND			±100	mA
T <sub>stg</sub>	g Storage temperature range			150	°C

<sup>(1)</sup> Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

#### 7.2 ESD Ratings

			VALUE	UNIT
V <sub>(ESD)</sub>		Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins (1)	2000	
	Electrostatic discharge	Charged device model (CDM), per JEDEC specification JESD22-C101, all pins (2)	1500	V

<sup>1)</sup> JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

<sup>(2)</sup> The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed.

<sup>(3)</sup> The value of V<sub>CC</sub> is provided in the *Recommended Operating Conditions* table.

<sup>(2)</sup> JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.



## 7.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

			MIN	MAX	UNIT
17	Cumply voltage	Operating	1.65	3.6	V
$V_{CC}$	Supply voltage	Data retention only	1.5		V
		V <sub>CC</sub> = 1.65 V to 1.95 V	0.65 × V <sub>CC</sub>		
$V_{IH}$	High-level input voltage	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	1.7		V
		V <sub>CC</sub> = 2.7 V to 3.6 V	2		
		V <sub>CC</sub> = 1.65 V to 1.95 V		0.35 × V <sub>CC</sub>	
$V_{IL}$	Low-level input voltage	V <sub>CC</sub> = 2.3 V to 2.7 V		0.7	V
		V <sub>CC</sub> = 2.7 V to 3.6 V		0.8	
V <sub>I</sub>	Input voltage		0	5.5	V
1/	Output voltage	High or low state	0	V <sub>CC</sub>	V
Vo		3-state	0	5.5	v
		V <sub>CC</sub> = 1.65 V		-4	
	High level autout august	V <sub>CC</sub> = 2.3 V		-8	A
I <sub>OH</sub>	High-level output current	V <sub>CC</sub> = 2.7 V		-12	mA
		V <sub>CC</sub> = 3 V		-24	
		V <sub>CC</sub> = 1.65 V		4	
	Lave lavel autout average	V <sub>CC</sub> = 2.3 V		8	A
l <sub>OL</sub>	Low-level output current	V <sub>CC</sub> = 2.7 V		12	mA
		V <sub>CC</sub> = 3 V		24	
Δt/Δν	Input transition rise or fall rate			10	ns/V
T <sub>A</sub>	Operating free-air temperature		-40	125	°C

<sup>(1)</sup> All unused control inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs* (SCBA004).

#### 7.4 Thermal Information

THERMAL METRIC <sup>(1)</sup>		DGG	DGV	DL	UNIT		
			56 PINS				
$R_{\theta JA}$	Junction-to-ambient thermal resistance	60.6	72.8	53.1			
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	17.9	27.5	18.3			
$R_{\theta JB}$	Junction-to-board thermal resistance	29.4	38.3	25.8	°C/W		
ΨЈТ	Junction-to-top characterization parameter	0.8	1.7	1.4			
ΨЈВ	Junction-to-board characterization parameter	29.1	37.8	25.6			

(1) For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report, SPRA953.



#### 7.5 Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

545		TEST CONDI	-10110	.,	T <sub>A</sub> =	= 25°C		–40°C to 8	35°C	-40°C to 12		
PAF	RAMETER	TEST CONDITIONS		V <sub>cc</sub>	MIN	TYP <sup>(1)</sup>	MAX	MIN	MAX	MIN	MAX	UNIT
		I <sub>OH</sub> = -100 μA		1.65 V to 3.6 V	V <sub>CC</sub> - 0.2			V <sub>CC</sub> - 0.2		V <sub>CC</sub> - 0.2		
		$I_{OH} = -4 \text{ mA}$		1.65 V	1.2			1.2		1.2		
$V_{OH}$		$I_{OH} = -8 \text{ mA}$		2.3 V	1.7			1.7		1.7		V
		I <sub>OH</sub> = -12 mA		2.7 V	2.2			2.2		2.2		
		10H = -12 IIIA		3 V	2.4			2.4		2.4		
		$I_{OH} = -24 \text{ mA}$		3 V	2.2			2.2		2.2		
		I <sub>OL</sub> = 100 μA		1.65 V to 3.6 V			0.2		0.2		0.2	
$V_{OL}$		I <sub>OL</sub> = 4 mA		1.65 V			0.45		0.45		0.45	V
VOL		I <sub>OL</sub> = 8 mA		2.3 V			0.7		0.7		0.7	<b>v</b>
		I <sub>OL</sub> = 12 mA		2.7 V			0.4		0.4		0.4	
		I <sub>OL</sub> = 24 mA		3 V			0.55		0.55		0.55	
I	Control inputs	V <sub>I</sub> = 0 to 5.5 V		3.6 V			±5		±5		±5	μΑ
		V <sub>I</sub> = 0.58 V		1.65 V -	See <sup>(2)</sup>			See <sup>(2)</sup>		See <sup>(2)</sup>		
	$V_{I} = 1.07 \text{ V}$ $V_{I} = 0.7 \text{ V}$	V <sub>I</sub> = 1.07 V			See <sup>(2)</sup>			See <sup>(2)</sup>		See <sup>(2)</sup>		
		V <sub>I</sub> = 0.7 V			45			45		45		μΑ
$I_{I(hold)}$	A or B ports	V <sub>I</sub> = 1.7 V		2.3 V	-45			-45		-45		
	porto	$V_1 = 0.8 \text{ V}$		3 V	75			75		75		
		V <sub>I</sub> = 2 V		3 V	-75			<b>-</b> 75		-75		
		$V_I = 0 \text{ to } 3.6 \text{ V}^{(3)}$		3.6 V			±500		±500		±500	i
I <sub>off</sub>		$V_I$ or $V_O = 5.5 \text{ V}$		0			±10		±10		±10	μΑ
I <sub>OZ</sub> <sup>(4)</sup>		V <sub>O</sub> = 0 V or (V <sub>CC</sub> to 5.5	(V)	2.3 V to 3.6 V			±5		±5		±5	μA
		V <sub>I</sub> = V <sub>CC</sub> or GND					20		20		20	
I <sub>CC</sub>		$3.6 \text{ V} \le \text{V}_{\text{I}} \le 5.5 \text{ V}^{(5)}$	$I_0 = 0$	3.6 V			20		20		20	μΑ
$\Delta I_{CC}$		One input at V <sub>CC</sub> - 0.6 Other inputs at V <sub>CC</sub> or	S V, GND	2.7 V to 3.6 V			500		500		500	μA
C <sub>i</sub>	Control inputs	V <sub>I</sub> = V <sub>CC</sub> or GND		3.3 V		5						pF
C <sub>io</sub>	A or B ports	$V_O = V_{CC}$ or GND		3.3 V		8						pF

(5) This applies in the disabled state only.

<sup>(1)</sup> All typical values are at  $V_{CC} = 3.3 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$ . (2) This information was not available at the time of publication.

This is the bus-hold maximum dynamic current required to switch the input from one state to another.

For the total leakage current in an I/O port, please consult the  $I_{I(hold)}$  specification for the input voltage condition 0 V <  $V_I$  <  $V_{CC}$ , and the  $I_{OZ}$  specification for the input voltage conditions  $V_I$  = 0 V or  $V_I$  =  $V_{CC}$  to 5.5 V. The bus-hold current, at input voltage greater than  $V_{CC}$ , is negligible.



#### 7.6 Timing Requirements, 40°C to 85°C

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 3)

		V <sub>CC</sub> = 1.8 V ± 0.15 V		V <sub>CC</sub> = 2.5 V ± 0.2 V		V <sub>CC</sub> =	2.7 V	V <sub>CC</sub> = 3.3 V ± 0.3 V		UNIT
		MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
f <sub>clock</sub>	Clock frequency		120		150		150		150	MHz
t <sub>w</sub>	Pulse duration, CLK high or low	See <sup>(1)</sup>		See <sup>(1)</sup>		3.3		3.3		ns
t <sub>su</sub>	Setup time, A or B before CLKAB↑ or CLKBA↑	5		3.8		3.4		3		ns
t <sub>h</sub>	Hold time, A or B after CLKAB↑ or CLKBA↑	0.7		0.5		0		0.2		ns

<sup>(1)</sup> This information was not available at the time of publication.

### 7.7 Timing Requirements, 40°C to 125°C

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 3)

		V <sub>CC</sub> = ± 0.1				V <sub>CC</sub> =	2.7 V	V <sub>CC</sub> = 3.3 V ± 0.3 V		UNIT
		MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
f <sub>clock</sub>	Clock frequency		120		150		150		150	MHz
t <sub>w</sub>	Pulse duration, CLK high or low	See <sup>(1)</sup>		See <sup>(1)</sup>		3.3		3.3		ns
t <sub>su</sub>	Setup time, A or B before CLKAB↑ or CLKBA↑	5.3		3.5		3.4		3		ns
t <sub>h</sub>	Hold time, A or B after CLKAB↑ or CLKBA↑	0.8		0.5		0		0.2		ns

<sup>(1)</sup> This information was not available at the time of publication.

### 7.8 Switching Characteristics, 40°C to 85°C

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 3)

PARAMETER	FROM	_		FROM 10 ± 0.15 V		V <sub>CC</sub> = 2.5 V ± 0.2 V		V <sub>CC</sub> = 2.7 V		V <sub>CC</sub> = 3.3 V ± 0.3 V		UNIT
	(INPUT)	(OUTPUT)	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX		
f <sub>max</sub>				120		150		150		150	MHz	
	A or B	B or A	9.1	11.8	6.9	8.6		6.4	1.4	6.3		
t <sub>pd</sub>	CLKAB or CLKBA	A or B		10.4		7.3		7.3	2.4	6.4	ns	
	SAB or SBA	B or A		12.5		9.6		8.8	1.9	7.4		
t <sub>en</sub>	OE or OE	A or B		23.4		9.3		6.6	1.6	6.3	ns	
t <sub>dis</sub>	OE or OE	A or B		15.9		8.2		6.6	1.2	6.2	ns	

#### 7.9 Switching Characteristics, 40°C to 125°C

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 3)

	1 0					, ,	0	,			
PARAMETER	ARAMETER FROM		V <sub>CC</sub> = 1 ± 0.15		V <sub>CC</sub> = ± 0.	2.5 V 2 V	V <sub>CC</sub> =	2.7 V	V <sub>CC</sub> = ± 0.	3.3 V 3 V	UNIT
	(INPUT)	(OUTPUT)	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
f <sub>max</sub>				120		150		150		150	MHz
	A or B	B or A		10		7.6		6.4	1.4	6.3	
t <sub>pd</sub>	CLKAB or CLKBA	A or B		11.6		9.1		7.3	2.4	6.4	ns
	SAB or SBA	B or A		13.1		9.9		8.8	1.9	7.4	
t <sub>en</sub>	OE or OE	A or B		2.1		8.5		6.6	1.6	6.3	ns
t <sub>dis</sub>	OE or OE	A or B		18.6		8.2		6.6	1.2	6.2	ns



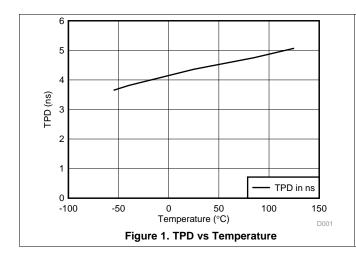
## 7.10 Operating Characteristics

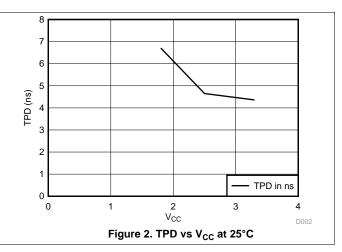
 $T_{\Delta} = 25^{\circ}C$ 

	PARAMETER		TEST CONDITIONS	V <sub>CC</sub> = 1.8 V ± 0.15 V	V <sub>CC</sub> = 2.5 V ± 0.2 V	V <sub>CC</sub> = 3.3 V ± 0.3 V	UNIT	
			TYP	TYP	TYP			
Power dissipation capacitance		Outputs enabled	f 40 MHz	See (1)	See (1)	55	nΕ	
C <sub>pd</sub>	per transceiver	Outputs disabled	f = 10 MHz	See <sup>(1)</sup>	See <sup>(1)</sup>	12	pF	

<sup>(1)</sup> This information was not available at the time of publication.

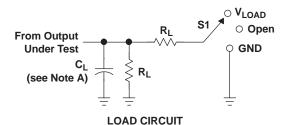
## 7.11 Typical Characteristics





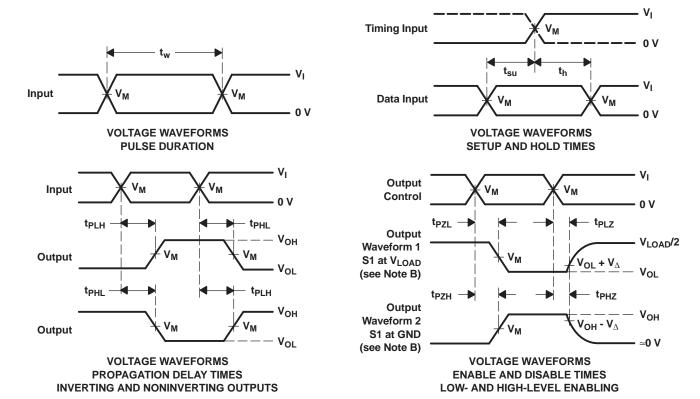


#### 8 Parameter Measurement Information



TEST	S1
t <sub>PLH</sub> /t <sub>PHL</sub>	Open
t <sub>PLZ</sub> /t <sub>PZL</sub>	V <sub>LOAD</sub>
t <sub>PHZ</sub> /t <sub>PZH</sub>	GND

V	INF	PUTS	V	V	•		V
V <sub>CC</sub>	VI	t <sub>r</sub> /t <sub>f</sub>	V <sub>M</sub>	V <sub>LOAD</sub>	CL	R <sub>L</sub>	$V_{\!\scriptscriptstyle \Delta}$
1.8 V ± 0.15 V	V <sub>CC</sub>	≤2 ns	V <sub>CC</sub> /2	2×V <sub>CC</sub>	30 pF	<b>1 k</b> Ω	0.15 V
2.5 V $\pm$ 0.2 V	V <sub>CC</sub>	≤2 ns	V <sub>CC</sub> /2	2 × V <sub>CC</sub>	30 pF	<b>500</b> Ω	0.15 V
2.7 V	2.7 V	≤2.5 ns	1.5 V	6 V	50 pF	<b>500</b> Ω	0.3 V
3.3 V $\pm$ 0.3 V	2.7 V	≤2.5 ns	1.5 V	6 V	50 pF	500 Ω	0.3 V



NOTES: A. C<sub>L</sub> includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_O = 50 \Omega$ .
- D. The outputs are measured one at a time, with one transition per measurement.
- E. t<sub>PLZ</sub> and t<sub>PHZ</sub> are the same as t<sub>dis</sub>.
- F. t<sub>PZL</sub> and t<sub>PZH</sub> are the same as t<sub>en</sub>.
- G. t<sub>PLH</sub> and t<sub>PHL</sub> are the same as t<sub>pd</sub>.
- H. All parameters and waveforms are not applicable to all devices.

Figure 3. Load Circuit and Voltage Waveforms

Submit Documentation Feedback

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## 9 Detailed Description

#### 9.1 Overview

This 16-bit bus transceiver and register is designed for 1.65-V to 3.6-V  $V_{CC}$  operation.

The SN74LVCH16652A device consists of D-type flip-flops and control circuitry arranged for multiplexed transmission of data directly from the data bus or from the internal storage registers. The device can be used as two 8-bit transceivers or one 16-bit transceiver.

Complementary output-enable (OEAB and OEBA) inputs control the transceiver functions. Select-control (SAB and SBA) inputs select whether real-time or stored data is transferred. A low input level selects real-time data, and a high input level selects stored data. The circuitry used for select control eliminates the typical decoding glitch that occurs in a multiplexer during the transition between stored and real-time data. Figure 5 illustrates the four fundamental bus-management functions that can be performed with SN74LVCH16652A.

Data on the A or B bus, or both, can be stored in the internal D flip-flops by low-to-high transitions at the appropriate clock (CLKAB or CLKBA) inputs, regardless of the levels on the select-control or output-enable inputs. When SAB and SBA are in the real-time transfer mode, it also is possible to store data without using the internal D-type flip-flops by simultaneously enabling OEAB and OEBA. In this configuration, each output reinforces its input. When all other data sources to the two sets of bus lines are at high impedance, each set of bus lines remains at its last level configuration.

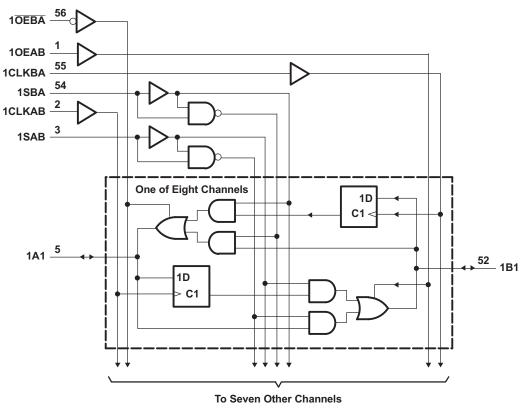
To ensure the high-impedance state during power up or power down,  $\overline{\text{OEBA}}$  should be tied to  $V_{CC}$  through a pull-up resistor and OEAB should be tied to GND through a pull-down resistor; the minimum value of the resistor is determined by the current-sinking/current-sourcing capability of the driver.

Inputs can be driven from either 3.3-V or 5-V devices. This feature allows the use of these devices as translators in a mixed 3.3-V/5-V system environment.

Active bus-hold circuitry is provided to hold unused or floating data inputs at a valid logic level. Use of pull-up or pull-down resistors with the <u>bus-hold</u> circuitry is not recommended. The bus-hold circuitry is part of the input circuit and is not disabled by  $\overline{\sf OE}$  or DIR.



## 9.2 Functional Block Diagram



20EBA 29
20EAB 28
30
2CLKBA 31
2SBA 27
2CLKAB 26

One of Eight Channels

To Seven Other Channels

Figure 4. Logic Diagram (Positive Logic)



### 9.3 Feature Description

- Wide operating voltage range
  - Operates from 1.65 V to 3.6 V
- Allows down voltage translation
  - Inputs accept voltages to 5.5 V
- I<sub>off</sub> feature
  - $-\,\,$  Allows voltages on the inputs and outputs when  $V_{CC}$  is 0 V
- Bus hold on data Inputs eliminates the need for external pull-up/pull-down resistors

### 9.4 Device Functional Modes

**Table 1. Function Table** 

		INP	UTS			DATA	. I/O <sup>(1)</sup>	OPERATION OR FUNCTION
OEAB	OEBA	CLKAB	CLKBA	SAB	SBA	A1-A8	B1-B8	OPERATION OR FUNCTION
L	Н	H or L	H or L	Χ	Χ	Input	Input	Isolation
L	Н	<b>↑</b>	<b>↑</b>	Χ	X	Input	Input	Store A and B data
X	Н	1	H or L	Χ	Χ	Input	Unspecified (2)	Store A, hold B
Н	Н	<b>↑</b>	<b>↑</b>	X <sup>(2)</sup>	X	Input	Output	Store A in both registers
L	Χ	H or L	<b>↑</b>	Χ	Х	Unspecified <sup>(2)</sup>	Input	Hold A, store B
L	L	<b>↑</b>	<b>↑</b>	Χ	X <sup>(2)</sup>	Output	Input	Store B in both registers
L	L	Χ	Χ	Χ	L	Output	Input	Real-time B data to A bus
L	L	Χ	H or L	Χ	Н	Output	Input	Stored B data to A bus
Н	Н	Χ	Χ	L	Х	Input	Output	Real-time A data to B bus
Н	Н	H or L	Χ	Н	X	Input	Output	Stored A data to B bus
Н	L	H or L	H or L	Н	Н	Output	Output	Stored A data to B bus and stored B data to A bus

The data-output functions may be enabled or disabled by a variety of level combinations at OEAB or OEBA. Data-input functions always are enabled; i.e., data at the bus terminals is stored on every low-to-high transition of the clock inputs. Select control = L; clocks can occur simultaneously.

Select control = H; clocks must be staggered to load both registers.



## 10 Application and Implementation

#### 10.1 Application Information

SN74LVCH16652A is a high-drive CMOS device that can be used for a multitude of bus interface type applications where the data needs to be retained or latched. It can produce 24 mA of drive current at 3.3 V, making it Ideal for driving multiple outputs and good for high-speed applications up to 100 MHz. To ensure the high-impedance state during power up or power down,  $\overline{\text{OEBA}}$  should be tied to  $V_{CC}$  through a pull-up resistor and OEAB should be tied to GND through a pull-down resistor; the minimum value of the resistor is determined by the current-sinking/current-sourcing capability of the driver. Inputs can be driven from either 3.3-V or 5-V devices. This feature allows the use of these devices as translators in a mixed 3.3-V/5-V system environment. Active bus-hold circuitry is provided to hold unused or floating data inputs at a valid logic level. Use of pull-up or pull-down resistors with the bus-hold circuitry is not recommended. The bus-hold circuitry is part of the input circuit and is not disabled by any control pin.

#### 10.2 Typical Application

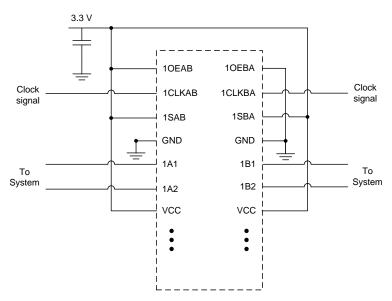


Figure 5. Bus-Management Functions

#### 10.2.1 Design Requirements

This device uses CMOS technology and has balanced output drive. Care should be taken to avoid bus contention because it can drive currents that would exceed maximum limits. The high drive will also create fast edges into light loads, so routing and load conditions should be considered to prevent ringing.

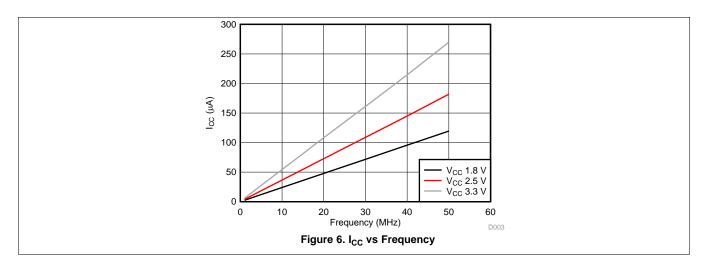
#### 10.2.2 Detailed Design Procedure

- 1. Recommended Input Conditions
  - For rise time and fall time specifications, see Δt/ΔV in the Recommended Operating Conditions table.
  - For specified High and low levels, see V<sub>IH</sub> and V<sub>IL</sub> in the Recommended Operating Conditions table.
  - Inputs are overvoltage tolerant allowing them to go as high as 5.5 V at any valid  $V_{\rm CC}$ .
- 2. Recommend Output Conditions
  - Load currents should not exceed 50 mA per output and 100 mA total for the part.
  - Outputs should not be pulled above V<sub>CC</sub>.



#### **Typical Application (continued)**

#### 10.2.3 Application Curves



## 11 Power Supply Recommendations

The power supply can be any voltage between the MIN and MAX supply voltage rating located in the *Recommended Operating Conditions* table.

Each  $V_{CC}$  pin should have a good bypass capacitor to prevent power disturbance. For devices with a single supply, 0.1  $\mu$ F is recommended. If there are multiple  $V_{CC}$  pins, 0.01  $\mu$ F or 0.022  $\mu$ F is recommended for each power pin. It is acceptable to parallel multiple bypass caps to reject different frequencies of noise. A 0.1  $\mu$ F and 1  $\mu$ F are commonly used in parallel. The bypass capacitor should be installed as close to the power pin as possible for best results.



## 12 Layout

#### 12.1 Layout Guidelines

When using multiple bit logic devices, inputs should not float. In many cases, functions or parts of functions of digital logic devices are unused. Some examples are when only two inputs of a triple-input AND gate are used. or when only 3 of the 4-buffer gates are used. Such input pins should not be left unconnected because the undefined voltages at the outside connections result in undefined operational states.

Specified in Figure 7 are rules that must be observed under all circumstances. All unused inputs of digital logic devices must be connected to a high or low bias to prevent them from floating. The logic level that should be applied to any particular unused input depends on the function of the device. Generally they will be tied to GND or V<sub>CC</sub>, whichever makes more sense or is more convenient. It is acceptable to float outputs unless the part is a transceiver.

#### 12.2 Layout Example

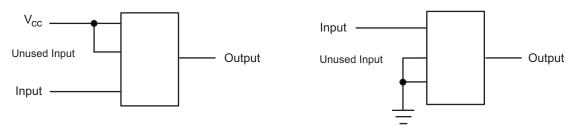


Figure 7. Layout Diagram

## 13 Device and Documentation Support

#### 13.1 Trademarks

Widebus is a trademark of Texas Instruments.

All other trademarks are the property of their respective owners.

#### 13.2 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

#### 13.3 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

## Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.





6-Feb-2020

#### **PACKAGING INFORMATION**

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty		Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
SN74LVCH16652ADGGR	ACTIVE	TSSOP	DGG	56	2000	Green (RoHS & no Sb/Br)	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LVCH16652A	Samples
SN74LVCH16652ADGVR	ACTIVE	TVSOP	DGV	56	2000	Green (RoHS & no Sb/Br)	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LDH652A	Samples
SN74LVCH16652ADL	ACTIVE	SSOP	DL	56	20	Green (RoHS & no Sb/Br)	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LVCH16652A	Samples
SN74LVCH16652ADLG4	ACTIVE	SSOP	DL	56	20	Green (RoHS & no Sb/Br)	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LVCH16652A	Samples

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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## **PACKAGE OPTION ADDENDUM**

6-Feb-2020

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## PACKAGE MATERIALS INFORMATION

www.ti.com 9-Aug-2014

## TAPE AND REEL INFORMATION





	Dimension designed to accommodate the component width
	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74LVCH16652ADGGR	TSSOP	DGG	56	2000	330.0	24.4	8.6	15.6	1.8	12.0	24.0	Q1
SN74LVCH16652ADGVR	TVSOP	DGV	56	2000	330.0	24.4	6.8	11.7	1.6	12.0	24.0	Q1

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#### \*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74LVCH16652ADGGR	TSSOP	DGG	56	2000	367.0	367.0	45.0
SN74LVCH16652ADGVR	TVSOP	DGV	56	2000	367.0	367.0	45.0

## DGV (R-PDSO-G\*\*)

#### **24 PINS SHOWN**

#### **PLASTIC SMALL-OUTLINE**



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15 per side.

D. Falls within JEDEC: 24/48 Pins – MO-153 14/16/20/56 Pins – MO-194

# DL (R-PDSO-G56)

## PLASTIC SMALL-OUTLINE PACKAGE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
- D. Falls within JEDEC MO-118

PowerPAD is a trademark of Texas Instruments.





SMALL OUTLINE PACKAGE



#### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
  4. Reference JEDEC registration MO-153.



SMALL OUTLINE PACKAGE



NOTES: (continued)

- 5. Publication IPC-7351 may have alternate designs.
- 6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE PACKAGE



NOTES: (continued)

- Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 8. Board assembly site may have different recommendations for stencil design.



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